



UNISONIC TECHNOLOGIES CO., LTD

UT25P03

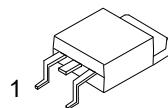
Power MOSFET

-25A, -30V P-CHANNEL
POWER MOSFET

■ DESCRIPTION

The UTC **UT25P03** The UTC **UT25P02L** is a P-channel power MOSFET using UTC's advanced technology.

The advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength.



TO-252

■ FEATURES

* $R_{DS(ON)} \leq 52 \text{ m}\Omega$ @ $V_{GS}=-10\text{V}$, $I_D =-10\text{A}$

$R_{DS(ON)} \leq 90 \text{ m}\Omega$ @ $V_{GS}=-4.5\text{V}$, $I_D =-10\text{A}$

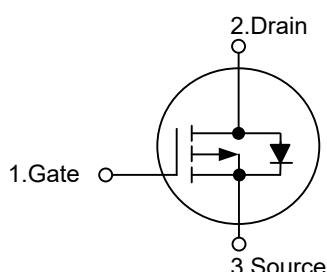
* Low Capacitance

* Optimized gate charge

* Fast switching capability

* Avalanche energy specified

■ SYMBOL



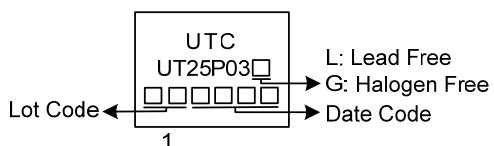
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UT25P03L-TN3-R	UT25P03G-TN3-R	TO-252	G	D	S	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

UT25P03G-TN3-R	(1)Packing Type (2)Package Type (3)Green Package	(1) R: Tape Reel (2) TN3: TO-252 (3) G: Halogen Free and Lead Free, L: Lead Free
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■ MARKING



■ ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	V_{DSS}	-30	V
Gate-Source Voltage	V_{GSS}	± 20	V
Continuous Drain Current	I_D	-25	A
Pulsed Drain Current (Note 2)	I_{DM}	-50	A
Avalanche Energy Single Pulsed (Note 3)	E_{AS}	22	mJ
Peak Diode Recovery dv/dt (Note 4)	dv/dt	0.3	V/ns
Power Dissipation	P_D	32	W
Junction Temperature	T_J	+150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. $L = 0.1\text{mH}$, $I_{AS} = -21\text{A}$, $V_{DD} = -25\text{V}$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$

4. $I_{SD} \leq -25\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	50	$^\circ\text{C}/\text{W}$
Junction to Case	θ_{JC}	3.9	$^\circ\text{C}/\text{W}$

Note: Device mounted on FR-4 substrate P_C board, 2oz copper, with 1inch square copper plate.

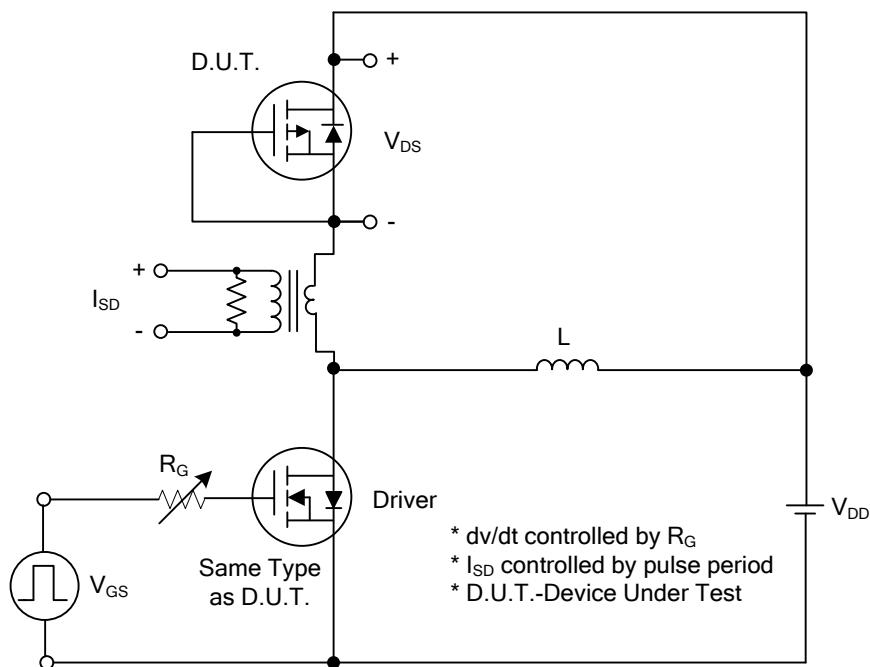
■ ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0\text{V}$, $I_D=-250\mu\text{A}$	-30			V
Drain-Source Leakage Current	I_{DS}	$V_{DS}=-30\text{V}$, $V_{GS}=0\text{V}$			-1	μA
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20\text{V}$, $V_{DS}=0\text{V}$			± 100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$	-1.0		-3.0	V
Static Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=-10\text{V}$, $I_D=-10\text{A}$			52	$\text{m}\Omega$
		$V_{GS}=-4.5\text{V}$, $I_D=-10\text{A}$			90	$\text{m}\Omega$
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{iss}	$V_{DS}=-25\text{V}$, $V_{GS}=0\text{V}$, $f=1.0\text{MHz}$		700		pF
Output Capacitance	C_{oss}			94		pF
Reverse Transfer Capacitance	C_{rss}			76		pF
SWITCHING CHARACTERISTICS						
Total Gate Charge (Note 1)	Q_G	$V_{DS}=-24\text{V}$, $V_{GS}=-10\text{V}$, $I_D=-25\text{A}$ (Note 1, 2)		32		nC
Gate-Source Charge	Q_{GS}			4.2		nC
Gate-Drain Charge	Q_{GD}			4.6		nC
Turn-On Delay Time (Note 1)	$t_{D(ON)}$	$V_{DS}=-15\text{V}$, $V_{GS}=-10\text{V}$, $I_D=-25\text{A}$, $R_G=3\Omega$ (Note 1, 2)		4.4		ns
Turn-On Rise Time	t_R			15		ns
Turn-Off Delay Time	$t_{D(OFF)}$			22		ns
Turn-Off Fall Time	t_F			19		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Continuous Drain-Source Diode Forward Current	I_S				-25	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				-50	A
Drain-Source Diode Forward Voltage (Note 1)	V_{SD}	$V_{GS}=0\text{V}$, $I_S = -10\text{A}$			-1.2	V

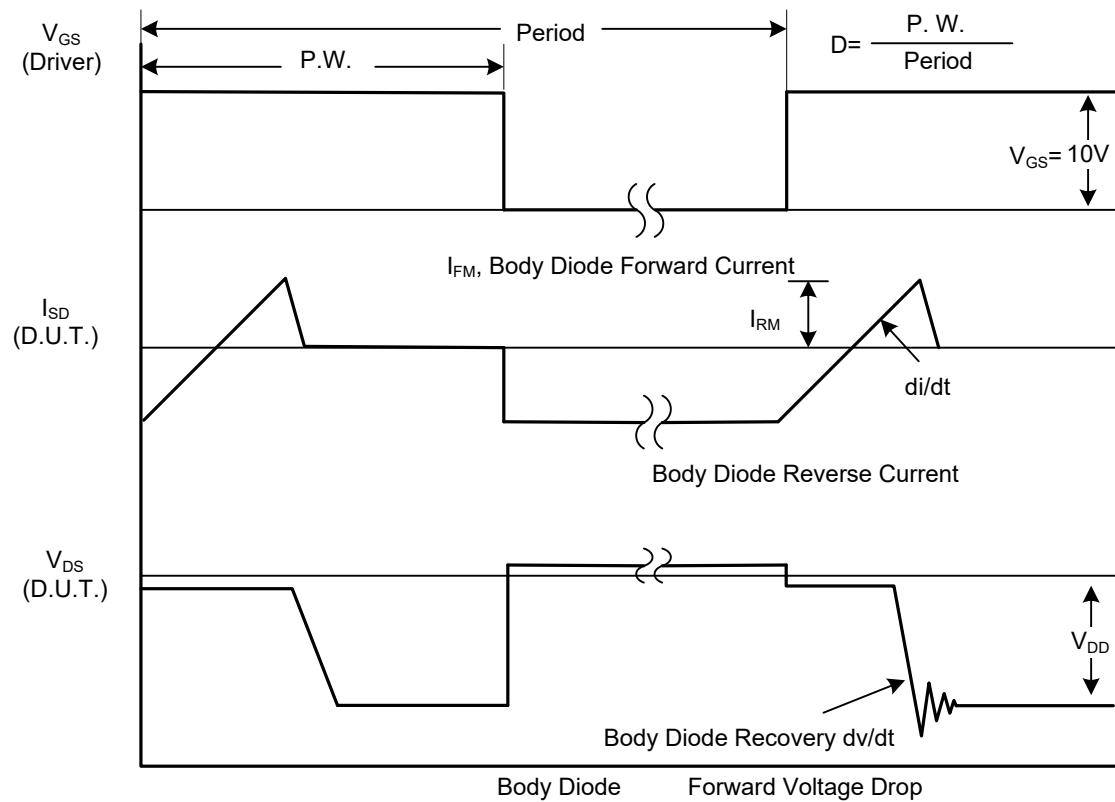
Notes: 1. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

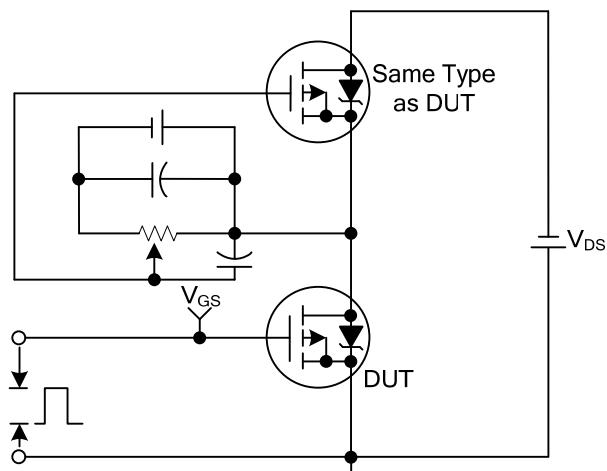


Peak Diode Recovery dv/dt Test Circuit

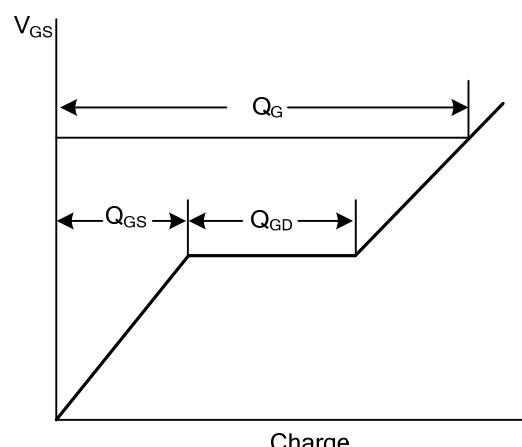


Peak Diode Recovery dv/dt Waveforms

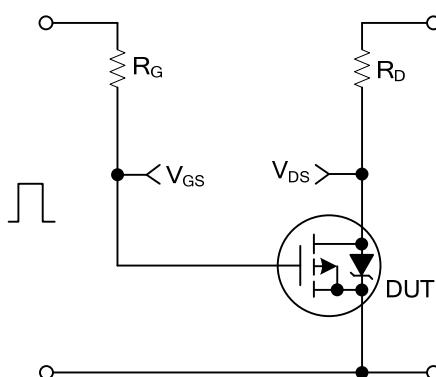
■ TEST CIRCUITS AND WAVEFORMS



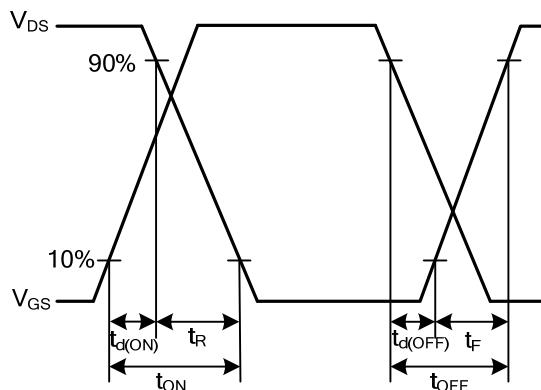
Gate Charge Test Circuit



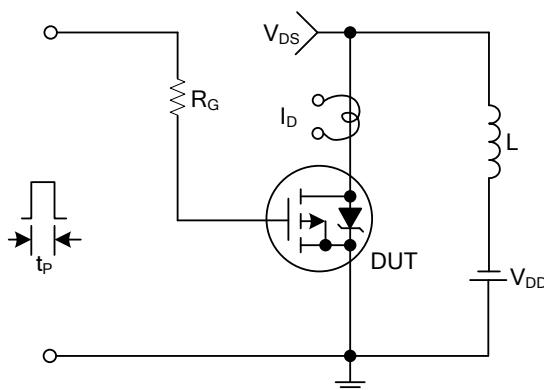
Gate Charge Waveforms



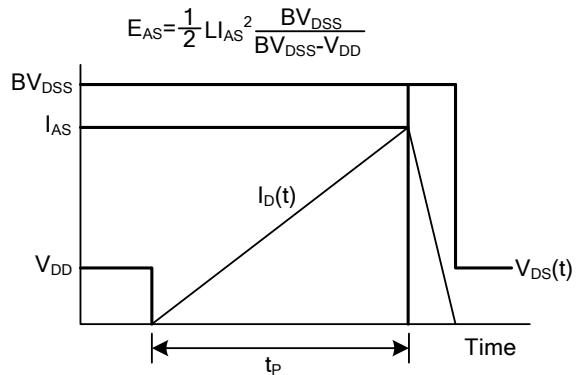
Resistive Switching Test Circuit



Resistive Switching Waveforms

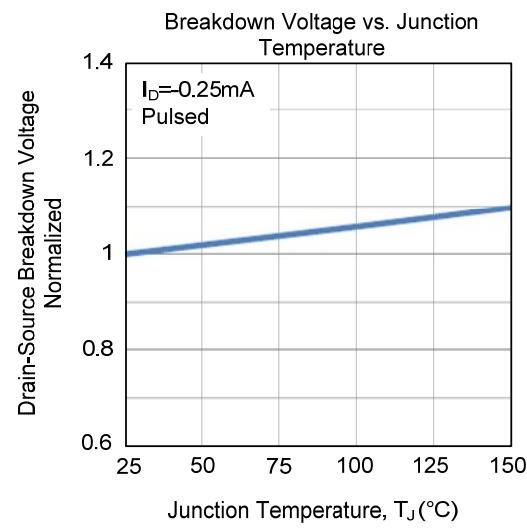
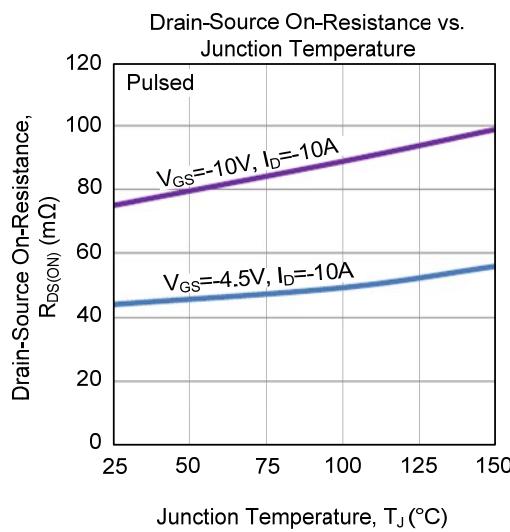
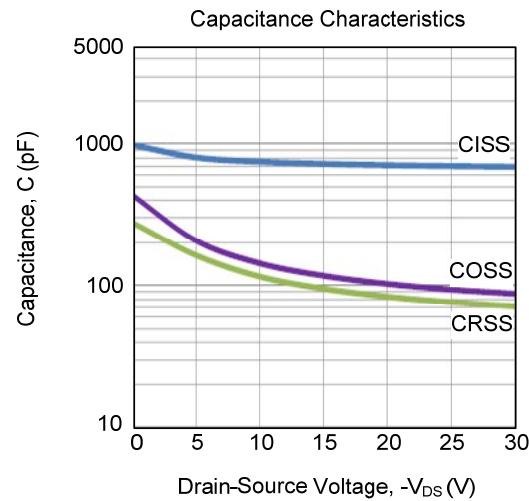
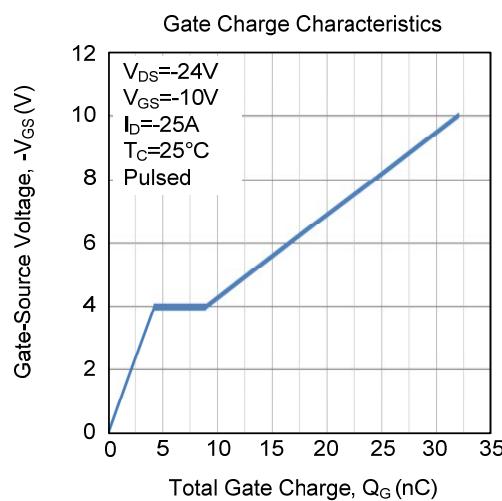
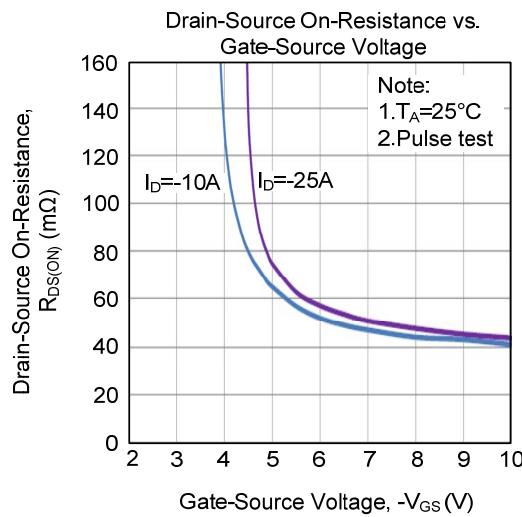
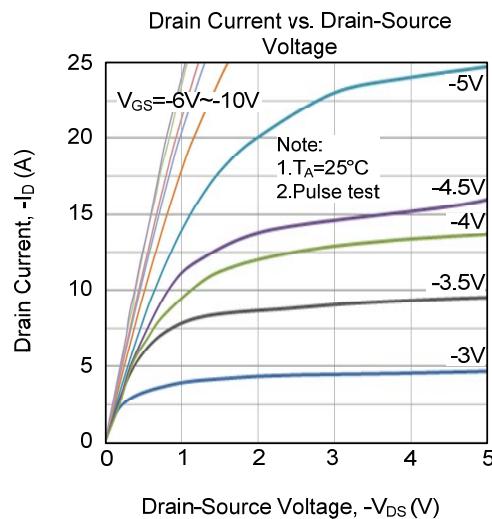


Unclamped Inductive Switching Test Circuit

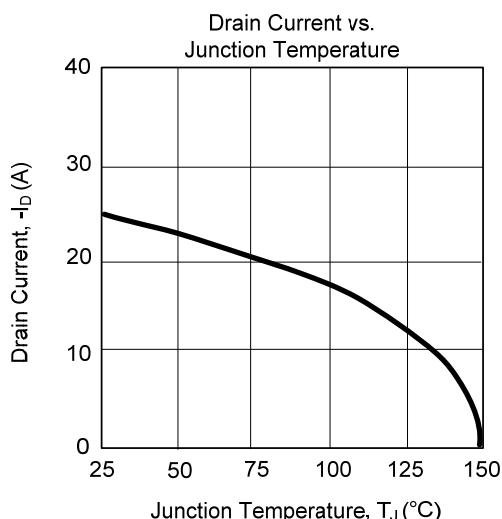
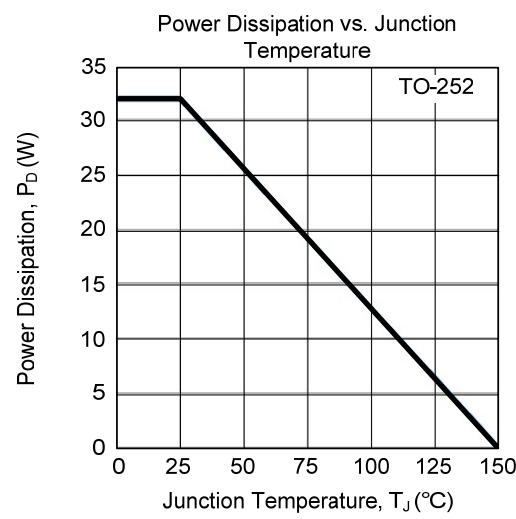
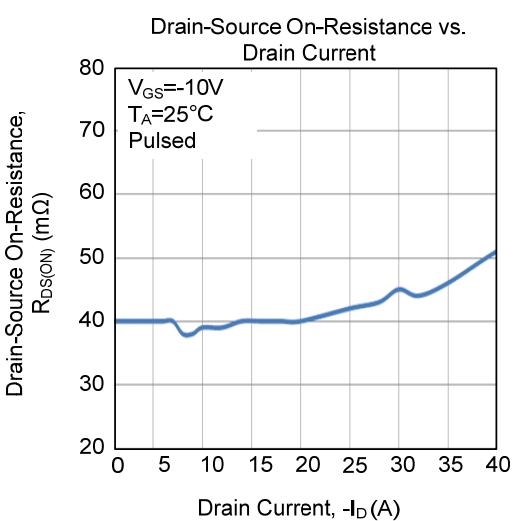
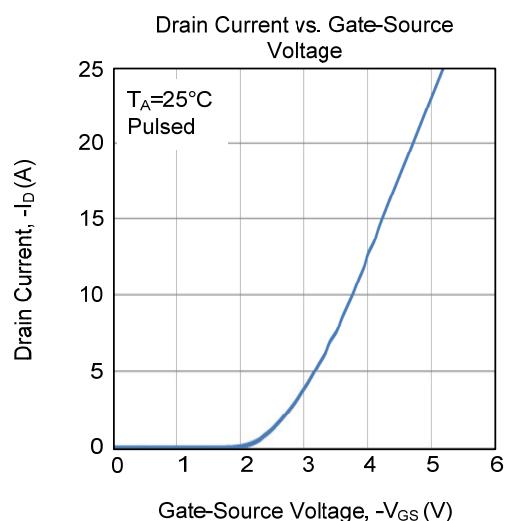
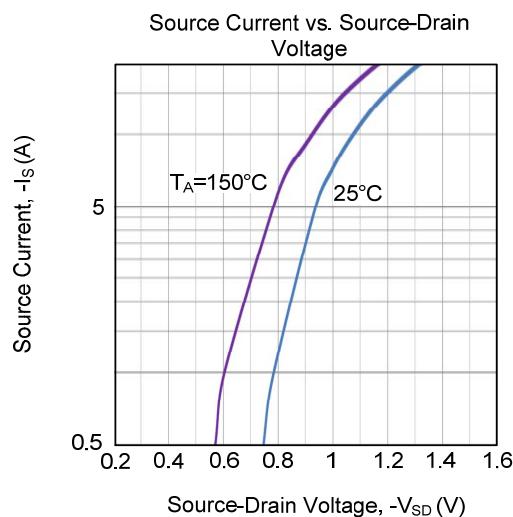
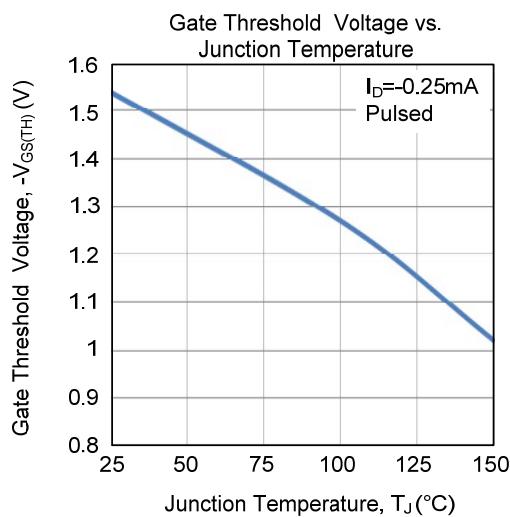


Unclamped Inductive Switching Waveforms

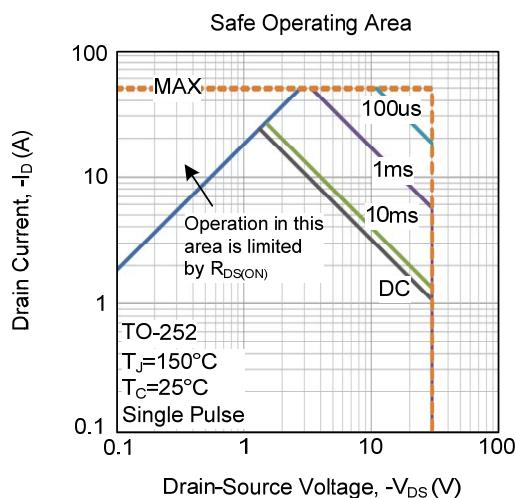
■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)



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